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# Discovery of superconductivity in Nb<sub>4</sub>SiSb<sub>2</sub> with a V<sub>4</sub>SiSb<sub>2</sub>-type structure and implications of interstitial doping on its physical properties†

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We report on the discovery, structural analysis, and the physical properties of Nb<sub>4</sub>SiSb<sub>2</sub> - a hitherto unknown compound crystallizing in the V<sub>4</sub>SiSb<sub>2</sub>-type structure with the tetragonal space group I4/mcm and unit cell parameters a = 10.3638(2) Å and c = 4.9151(2) Å. We find Nb<sub>4</sub>SiSb<sub>2</sub> to be a metal undergoing a transition to a superconducting state at a critical temperature of  $T_{c} \approx 1.6$  K. The bulk nature of the superconductivity in this material is confirmed by the observation of a well defined discontinuity in specific heat with a normalized specific heat jump of  $\Delta C(T_c)/\gamma T_c = 1.33$  mJ mol<sup>-1</sup> K<sup>-2</sup>. We find that for Nb<sub>4</sub>SiSb<sub>2</sub>, the unoccupied sites on the 4b Wyckoff position can be partially occupied with Cu, Pd, or Pt. Low-temperature resistivity measurements show transitions to superconductivity for all three compounds at  $T_c \approx 1.2$  K for Nb<sub>4</sub>Cu<sub>0.2</sub>SiSb<sub>2</sub>, and  $T_c \approx 0.8$  K for Nb<sub>4</sub>Pd<sub>0.2</sub>SiSb<sub>2</sub> as well as for Nb<sub>4</sub>Pt<sub>0.14</sub>SiSb<sub>2</sub>. The addition of electron-donor atoms into these void positions, henceforth, lowers the superconducting transition temperature in comparison to the parent compound

## 1 Introduction

A promising approach for the discovery of new superconducting materials is based on the substitution or incorporation of elements into existing structures with crystallographic void positions. Substituting or incorporating atoms into a structure allows for the precise chemical modification of the density of electronic states at the Fermi-level. This may induce superconductivity or tune superconducting properties. 1-5 Recent examples of this include the increase in the superconducting transition temperature of Nb<sub>5</sub>Ge<sub>3</sub> - in the tetragonal Cr<sub>5</sub>B<sub>3</sub> typestructure – from  $T_c \approx 0.7$  K to 15.3 K by the incorporation of carbon atoms into void positions,6 or the stabilization of η-carbide superconductors in a filled Ti<sub>2</sub>Ni-type structure, with remarkably high upper critical fields.4,7

The results presented in this paper refer to structures, crystallizing in a defect variant of the W<sub>5</sub>Si<sub>3</sub>-type structure, commonly known as the V<sub>4</sub>SiSb<sub>2</sub> structure. The W<sub>5</sub>Si<sub>3</sub> structure itself exhibits the tetragonal space group I4/mcm<sup>8</sup> and is a bulk superconductor with a critical temperature of  $T_c = 2.7 \text{ K.}^9 \text{ Other}$ compounds crystallizing in the same structure-type and exhibiting superconducting properties are Nb<sub>5</sub>Si<sub>3</sub> with a critical temperature of  $T_c = 0.7 \text{ K}$ , <sup>10</sup> and the ternary W<sub>5</sub>Si<sub>3</sub>-type compounds Nb<sub>5</sub>Sn<sub>2</sub>Ga, Ta<sub>5</sub>SnGa<sub>2</sub>, and Zr<sub>5</sub>Sb<sub>2,36</sub>Ru<sub>0,36</sub> with critical temperatures of  $T_c \approx 1.8 \text{ K}$ , 1.8 K, and 5 K, respectively. <sup>11–13</sup> In the V<sub>4</sub>SiSb<sub>2</sub> structure, the 4b Wyckoff position of the W<sub>5</sub>Si<sub>3</sub> structure is unoccupied, forming void channels along the c-direction. These channels are filled by Sb centred, essentially unhybridized 5p orbitals forming a 2D net stacking along the c-direction leading to "electron-filled" voids. 14 The prospect of intercalating these voids with electrophilic species has been theoretically proposed by Rytz et al. 14

To date, only six compounds have been reported to crystallize in this structure-type, namely V<sub>4</sub>SiSb<sub>2</sub> and the compound series of  $Ti_4TBi_2$  with (T = Cr, Mn, Fe, Co, Ni). All of these compounds are known to be non-magnetic metals. 15,16 Furthermore, 5 pseudo-quaternary antimonides with the general formula  $Nb_4Pd_{0.5}ZSb_2$  with Z = Cr, Fe, Co, Ni, Si have been reported.<sup>17</sup> These compounds contain three transition metals in an ordered arrangement; hence they are isostructural to each other and crystallize in substitutional variants of the W<sub>5</sub>Si<sub>3</sub>-type structure, or alternatively, they can be interpreted as V<sub>4</sub>SiSb<sub>2</sub>type compounds with half occupied channels.

Here, we report on the discovery of the compound Nb<sub>4</sub>SiSb<sub>2</sub>, which crystallizes in a V<sub>4</sub>SiSb<sub>2</sub>-type structure with the tetragonal space group I4/mcm. We show that this material exhibits

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bulk superconductivity at a critical temperature of  $T_c \approx 1.6$  K. Furthermore, we find that the 4b Wyckoff void position can be partially occupied by the transition metals Cu, Pd or Pt, leading the compounds Nb<sub>4</sub>Cu<sub>0.2</sub>SiSb<sub>2</sub>, Nb<sub>4</sub>Pd<sub>0.2</sub>SiSb<sub>2</sub>, and Nb<sub>4</sub>Pt<sub>0.14</sub>SiSb<sub>2</sub>. All three compounds are bulk superconductors with critical temperatures of  $T_c \approx 1.2$  K, 0.8 K, and 0.8 K, respectively.

# 2 Experimental

#### **Synthesis**

Polycrystalline samples of all compounds were obtained by solid state reaction of the pressed elemental powders at high temperatures. These were synthesized using pure elements as received and stored in air of niobium (powder, 99.99%, Alfa Aesar), silicon (pieces, 99.95%, Alfa Aesar), antimony (shots, 99.999%, Alfa Aesar), copper (powder, 99.7%, Merck), palladium (powder, 99.999%, Acros Organics) and platinum (powder, 99.999%, Acros Organics). The elements were thoroughly mixed and ground in their stoichiometric ratios, then pressed into pellets, and subsequently sealed in quartz ampoules under 400 mbar of Ar. The quartz ampoules were heated to T = 1100 °C with a heating rate of 180 °C h<sup>-1</sup>, and annealed at this temperature for 7 days.

#### Diffraction

Single crystal X-ray diffraction (SXRD) data were collected at T =160(1) K on a Rigaku XtaLAB Synergy, Dualflex, Pilatus 200K diffractometer using a monochromatic X-ray source (Cu  $K_{\alpha}$ radiation:  $\lambda = 1.54184 \text{ Å}$ ) from a micro-focus sealed X-ray tube and cooled using an Oxford liquid-nitrogen Cryostream device. The selected suitable single crystals were mounted using polybutene oil. Pre-experiment, data collection, data reduction and analytical absorption correction<sup>18</sup> were performed with the program suite CrysAlisPro. Using Olex2,19 the structure was solved with the SHELXT<sup>20</sup> small molecule structure solution program and refined with the SHELXL2018/3 program package<sup>21</sup> by full-matrix least-squares minimization on F2. PLATON<sup>22</sup> was used to check the result of the X-ray analysis. CCDC 2166026 (for Nb<sub>4</sub>Cu<sub>0.2</sub>SiSb<sub>2</sub>), 2166027 (for Nb<sub>4</sub>Pd<sub>0.2</sub>SiSb<sub>2</sub>), 2166028 (for Nb<sub>4</sub>Pt<sub>0.14</sub>SiSb<sub>2</sub>) and 2166029 (for Nb<sub>4</sub>SiSb<sub>2</sub>).†

Powder X-ray diffraction (PXRD) measurements were performed on a Rigaku SmartLab diffractometer using a Cu X-ray source  $(K_{\alpha_1} = 1.540600 \text{ Å}, K_{\alpha_2} = 1.544430 \text{ Å})$  with  $CuK_{\beta}$  filter and collected using a  $2\theta$  range of 5–100°. The machine is equipped with a 3 kW sealed X-ray tube, CBO optics and a D/teX Ultra 250 silicon strip detector. Data was recorded using the SmartLab Studio II software. Rietveld refinements were performed using the FULLPROF software package<sup>23</sup> and fitting of the diffracted data was done using the Thompson-Cox-Hastings pseudo-Voigt function with asymmetry correction.<sup>24</sup>

## Physical properties

Physical property measurements were carried out on sintered, flat pellets. Temperature-dependent resistivity measurements were

performed with a Quantum Design Physical Property Measurement System (PPMS) using a He-3 insert for temperature measurements down to 500 mK. A four-point resistivity measurement method, using silver wires (50 µm diameter) was employed.

Specific heat measurements were performed from 300 mK to 2 K in a He-3 15 T magnet cryostat with a custom-developed modulated-temperature AC calorimetry technique using an SR830 digital lock-in amplifier, and from 2-10 K with a long relaxation technique in a He-4 cryostat. For the latter, each relaxation provides about 1000 data points over a temperature interval of 30-40% of the base temperature, which has been varied between 2 K and 10 K. The relaxation technique provides a high precision up to 1% while the AC technique is less accurate but provides high resolutions of  $\Delta C/C$  of  $10^{-5}$  at a high density of data points.<sup>25</sup> Temperature-dependent magnetization measurements were performed using a Quantum Design Magnetic Properties Measurement System (MPMSXL) equipped with a reciprocating sample option (RSO) and a 7 T magnet.

## 3 Results and discussion

#### 3.1 Crystal Structure of Nb<sub>4</sub>SiSb<sub>2</sub>

In Fig. 1a and b, we present the crystal structure and the unit cell of the single-crystal refinement of Nb<sub>4</sub>SiSb<sub>2</sub>, shown along the cdirection and along the b-direction, respectively. The structure of Nb<sub>4</sub>SiSb<sub>2</sub> was determined by means of single crystal X-Ray diffraction (SXRD) at 160 K and the elemental composition was confirmed using EDX analysis at ambient temperature (ESI†).

We find Nb<sub>4</sub>SiSb<sub>2</sub> to crystallize in the tetragonal space group I4/mcm with the lattice parameters a = b = 10.3638(2) Å and c = 4.9151(2) Å with the corresponding calculated cell volume of  $V = 527.92(3) \text{ Å}^3$ . Hence, it is found to adopt the same centrosymmetric structure type that was previously reported for V<sub>4</sub>SiSb<sub>2</sub>. 15,16 The crystallographic data and the details of the structure refinement are summarised in Table 1. All crystallographic positions as well as the anisotropic displacement parameters are presented in Table 2.

In the structure of Nb<sub>4</sub>SiSb<sub>2</sub> each atom occupies one atomic site: the niobium atoms are located at the 16k Wyckoff position, silicon occupies the 4a and antimony the 8h Wyckoff positions. Silicon forms thereby columns which can be interpreted as  $_{\infty}[Nb_{8/2}Si]$  chains along the c-direction as shown in Fig. 1(c). The Si-Si bonding distance in Nb<sub>4</sub>SiSb<sub>2</sub> within the columns is 2.4576(1) Å, which is in good agreement with the ones found in V<sub>4</sub>SiSb<sub>2</sub><sup>15</sup> and comparable to Si-Si bond distances in similar structures. 17,26 Each Si atom is surrounded by eight Nb atoms with a distance of 2.6252(6) Å forming antiprisms with the surrounding neighbour atoms. Nb has a coordination number (CN) of 13 consisting of six Nb neighbours located in the  $_{\infty}[Nb_{8/2}Si]$  column, one Nb in the adjacent ∞[Nb<sub>8/2</sub>Si] column, two Si, and four Sb neighbours located in between the two columns. The Nb-Nb distances range from 3.0275(8) to 3.2807(9) Å. These distances, together with the relatively short intercolumn distance between two Nb atoms of 3.0449(13) Å are in good agreement with distances found in

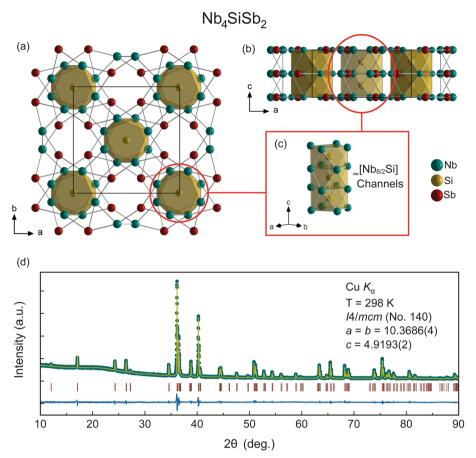


Fig. 1 Schematic representation of crystal structure obtained from SXRD refinement of Nb<sub>4</sub>SiSb<sub>2</sub> along (a) the c-direction and (b) the b-direction. (c) Si-Si chains along the c-direction. (d) PXRD pattern of the polycrystalline sample with the respective Rietveld refinement. Green dots: data points, yellow line: calculated peaks, vertical dark red lines: Bragg peak positions, and the blue pattern on the bottom is the difference plot.

comparable structures. 27,28 Also, the Nb-Sb distance ranging from 2.8238(7) Å to 2.9781(4) Å is in good agreement with the distances found in the related compounds, such as e.g. in Nb<sub>5</sub>Sb<sub>4</sub>.<sup>28</sup> Each Sb has eight Nb neighbours and therefore a CN of 8. Another feature of this structure are the voids at the 4b Wyckoff position. These void positions are surrounded by four Sb atoms. These form void channels along the *c*-direction. If these void positions were fully occupied, then the V<sub>4</sub>SiSb<sub>2</sub> structure would be equivalent to the W<sub>5</sub>Si<sub>3</sub> structure.<sup>15</sup>

The validity of the structural model, the phase purity, and the homogeneity of the sample were confirmed by means of PXRD at ambient temperature and SXRD at 160 K. The reliability factors of the SXRD refinement can be found in the ESI.† In Fig. 3(d) the PXRD pattern of the polycrystalline sample is shown, with its respective Rietveld refinement. We find the lattice parameters of a = b = 10.3686(4) Å, and c = 4.9193(2) Å, as well as a calculated cell volume of  $V = 528.86(3) \text{ Å}^3$ . Hence, the SXRD and PXRD refinements and structural solutions are in excellent agreement with each other (ESI†).

#### 3.2 Superconducting properties of Nb<sub>4</sub>SiSb<sub>2</sub>

In Fig. 2(a), we show the temperature-dependant resistivity of Nb<sub>4</sub>SiSb<sub>2</sub> in zero field  $\mu_0 H = 0T$  as  $\rho(T)$  between T = 300 K and

500 mK (inset) and in the vicinity of the superconducting transition. A sharp drop in the resistivity is observed at low temperature, corresponding to a transition to a superconducting state. The transition midpoint of  $T_{\rm c,mid} \approx 1.65$  K and reaches a state of zero resistance at  $T_{\rm zero} \approx 1.56$  K. The transition is comparably sharp with a transition width of  $\Delta T = 0.18$  K in the resistivity. The residual resistivity  $\rho(1.8 \text{ K}) = 0.14 \text{ m}\Omega$  cm at 1.8 K and the room temperature resistivity value of  $\rho(300 \text{ K}) = 2.06 \text{ m}\Omega$  cm, result in a residual resistivity ratio (RRR) here defined as RRR =  $\rho(300 \text{ K})/\rho(1.8 \text{ K})$  = 14.96. This RRR value corresponds to the value of a good metal.

The bulk nature of the superconductivity in Nb<sub>4</sub>SiSb<sub>2</sub> is confirmed by low-temperature specific-heat measurements. Temperature-dependent specific-heat measurements are of particular importance to prove the bulk nature of a superconductor.29,30

In Fig. 2(b), we present the temperature-dependent specific heat C(T)/T of Nb<sub>4</sub>SiSb<sub>2</sub> in a temperature range between T =600 mK and 2 K. We find a clearly pronounced discontinuity in the specific heat, resulting from the superconducting transition. The data was fitted using the  $\alpha$ -model.<sup>31,32</sup> Thereby, an entropy conserving construction was used to determine the critical temperature,  $T_{\rm c} \approx 1.6$  K. This value is in good

 $\textbf{Table 1} \quad \textbf{Details of the SXRD measurements and structural refinements for Nb_4SiSb_2, Nb_4Cu_{0.2}SiSb_2, Nb_4Pd_{0.2}SiSb_2 and Nb_4Pt_{0.14}SiSb_2 and Nb_4Pt_{0.14}SiSb_2, Nb_4Cu_{0.2}SiSb_2, Nb_4Cu_{0.2}SiSb_2 and Nb_4Pt_{0.14}SiSb_2 and Nb_4Pt_{0.14}SiSb_2, Nb_4Cu_{0.2}SiSb_2, Nb_4Cu_{0.2}SiSb_$ 

Parameters	$Nb_4SiSb_2$	$Nb_4Cu_{0.2}SiSb_2 \\$	$\mathrm{Nb_4Pd_{0.2}SiSb_2}$	$Nb_4Pt_{0.14}SiSb_2$
Crystal system	Tetragonal	Tetragonal	Tetragonal	Tetragonal
Structure-type	$V_4SiSb_2$	W <sub>5</sub> Si <sub>3</sub> (defect)	W <sub>5</sub> Si <sub>3</sub> (defect)	W <sub>5</sub> Si <sub>3</sub> (defect)
Space group	<i>I4/mcm</i> (No. 140)	I4/mcm (No. 140)	<i>I</i> 4/ <i>mcm</i> (No. 140)	<i>I4/mcm</i> (No. 140)
Absorption correction method	Analytical	Analytical	Spherical	Analytical
Temperature [K]	160(1)	160(1)	160(1)	160(1)
Lattice parameters [Å]	a = 10.3638(2)	a = 10.3954(2)	a = 10.3991(2)	a = 10.3803(2)
	c = 4.9151(2)	c = 4.9233(2)	c = 4.93619(16)	c = 4.9348(2)
Cell volume [Å <sup>3</sup> ]	527.92(3)	532.03(3)	533.81(3)	531.73(3)
Formula unit/cell	4	4	4	4
$\rho_{calcd} [\mathrm{g cm}^{-3}]$	8.093	8.189	8.268	8.376
$\mu  [\mathrm{mm}^{-1}]$	149.393	532.03(3)	153.021	155.001
Crystal size [mm]	$0.018 \times 0.016 \times 0.013$	$0.005 \times 0.003 \times 0.002$	$0.01 \times 0.01 \times 0.01$	$0.015 \times 0.015 \times 0.01$
F(000)	1120.0	1143.0	1157.0	1164.0
Radiation type	Cu $K_{\alpha}$ ( $\lambda = 1.54184$ )			
2Θ range [°]	12.078 to 146.58	12.04 to 148.58	12.036 to 147.576	12.058 to 147.716
Index range	h[-9,12]	h[-11,9]	h[-11,12]	h[-12,12]
	k[-12,12]	k[-12,12]	k[-12,12]	k[-12,12]
	l[-5,6]	l[-6,6]	l[-6,5]	l[-6,5]
Observed reflections	1466	838	2368	2381
Independent reflections $(2\sigma)$	165	166	166	167
R <sub>int</sub>	0.0278	0.0385	0.0312	0.0298
$R_{\sigma}$	0.0127	0.0314	0.0107	0.0117
Refined parameters	14	16	16	17
GOF	1.363	1.142	1.252	1.240
$R_1$ (all data) (%)	1.69	3.33	1.64	1.60
$WR_1 (\geq 2\sigma) (\%)$	1.69	2.96	1.62	1.57
wR <sub>2</sub> (all data) (%)	4.32	7.53	3.71	3.67
$WR_2 (\geq 2\sigma) (\%)$	4.33	7.37	3.71	3.66
Max/min residual electron density [e Å <sup>-3</sup> ]	1.41/-0.94	1.12/-1.52	0.97/-0.98	1.13/-0.85

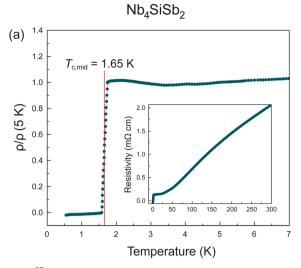
Table 2 Atomic coordinates, occupancy, isotropic and anisotropic displacement parameters of the SXRD refinements at 160 K under atmospheric pressure for the compounds Nb<sub>4</sub>SiSb<sub>2</sub>, Nb<sub>4</sub>Cu<sub>0.2</sub>SiSb<sub>2</sub>, Nb<sub>4</sub>Pd<sub>0.2</sub>SiSb<sub>2</sub> and Nb<sub>4</sub>Pt<sub>0.14</sub>SiSb<sub>2</sub> (Space Group I4/mcm, No. 140)

Atom	Wyckoff symbol	x	у	z	$U(eq) [\mathring{A}^2]$	$U_{11}/U_{22}$	$U_{33}$	$U_{12}$	Occ.
Nb <sub>4</sub> SiSb	$o_2$								
Nb	16k	0.29305(6)	0.58530(6)	1/2	0.0111(3)	10.6(4)/10.9(4)	11.8(4)	0.2(2)	4.00
Si	4a	1/2	1/2	3/4	0.0122(3)	10.1(11)/10.1(11)	16(2)	0	1.00
Sb	8h	0.14037(5)	0.35963(5)	1/2	0.0119(9)	11.8(3)/11.8(3)	13.0(5)	-1.5(3)	2.00
Nb <sub>4</sub> Cu <sub>0</sub>	$_2$ SiSb $_2$								
Nb	16k	0.29297(9)	0.41603(9)	1/2	0.0080(4)	6.2(6)/6.4(6)	11.4(6)	0.3(4)	4.00
Cu	4b	0	1/2	3/2	0.021(7)	24(8)/24(8)	16(12)	0	0.199(16)
Si	4a	1/2	1/2	3/2	0.0063(12)	3.2(17)/3.2(17)	12(3)	0	1.00
Sb	8h	0.14385(8)	0.35615(2)	1/2	0.0110(4)	8.8(5)/8.8(5)	15.3(7)	2.3(4)	2.00
Nb <sub>4</sub> Pd <sub>0</sub>	<sub>2</sub> SiSb <sub>2</sub>								
Nb	16k	0.29305(4)	0.58369(4)	1/2	0.0125(2)	12.1(3)/12.8(3)	12.7(3)	-0.01(17)	4.00
Pd	4b	0	1/2	1/4	0.0147(15)	13.6(16)/13.6(16)	17(2)	0	0.199(5)
Si	4a	1/2	1/2	3/2	0.0131(6)	13.1(8)/13.1(8)	13.0(14)	0	1.00
Sb	8h	0.14470(4)	0.35530(4)	1/2	0.0170(2)	15.8(2)/15.8(2)	19.5(3)	-3.5(2)	2.00
Nb <sub>4</sub> Pt <sub>0.7</sub>	4SiSb <sub>2</sub>								
Nb	16k	0.58429(5)	0.29284(5)	1/2	0.0063(2)	6.3(3)/6.2(3)	6.5(4)	-0.08(18)	4.00
Pt	4b	1/2	0	3/2	0.0122(5)	12.5(17)/12.5(17)	12(3)	0	0.140(3)
Si	4a	1/2	1/2	3/2	0.0020(6)	2.7(8)/2.7(8)	0.7(16)	0	1.00
Sb	8h	0.35697(4)	0.14303(4)	1/2	0.0101(3)	9.0(3)/9.0(3)	12.5(4)	-3.1(2)	2.00

agreement with the critical temperature from the resistivity measurement. From the  $\alpha$ -model fit, we obtained  $\alpha = 1.7$  and the Sommerfeld constant of  $\gamma = 9.00 \text{ mJ mol}^{-1} \text{ K}^{-2}$ . We find a ratio for the normalized specific-heat jump of  $\Delta C/\gamma T_c$  = 1.33 mJ mol<sup>-1</sup> K<sup>-2</sup>, which confirms the bulk nature of the

superconductivity, as this value is close to the weak-coupling BCS ratio of 1.43. This corresponds to a value of the superconducting gap of  $2\Delta(0) = 3.4k_BT_c$ .

Under the assumption of a degenerate electron gas of noninteracting particles, the electronic contribution to the heat



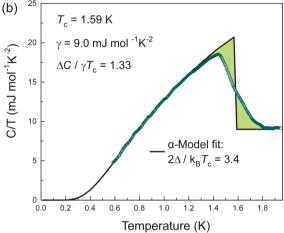


Fig. 2 (a) Normalized, low-temperature resistivity of Nb<sub>4</sub>SiSb<sub>2</sub> in a temperature range between T = 500 mK and 5 K measured in zero field  $\mu_0H$  = 0 T. Inset: Temperature-dependant resistivity of Nb<sub>4</sub>SiSb<sub>2</sub> in zero field  $\mu_0 H = 0$  T as  $\rho(T)$  between T = 500 mK and 300 K (b) Specific heat capacity of  $Nb_4SiSb_2$  in a temperature range between T = 580 mK and 2 K. The black line corresponds to a fit using the  $\alpha$ -model.

capacity in a solid at low temperatures is proportional to the density of states at the Fermi level  $D(E_F)$  and linear in T. With the previously determined value of  $\gamma = 9.00 \text{ mJ mol}^{-1} \text{ K}^{-2}$ , the density of states at the Fermi level can be calculated as described by F. Heiniger et al.33 according to

$$C_{\rm el} = \gamma T = \frac{\pi^2}{3} k_{\rm B}^2 D(E_{\rm F}) T.$$
 (1)

We obtain for Nb<sub>4</sub>SiSb<sub>2</sub> a density of states at the Fermi level of  $D(E_E) = 3.8 \text{ states eV}^{-1}$ .

Magnetic susceptibility measurements of Nb<sub>4</sub>SiSb<sub>2</sub> were conducted in the normal-state, i.e. in a temperature range between T = 10 K to 300 K, in an external field of  $\mu_0 H = 1$  T. The observed temperature-independent positive magnetic moment corresponds to a Pauli-paramagnet (see ESI†). A summary of all obtained physical parameters can be found in Table 3.

## 3.3 Crystal Structures of Nb<sub>4</sub>Cu<sub>0.2</sub>SiSb<sub>2</sub>, Nb<sub>4</sub>Pd<sub>0.2</sub>SiSb<sub>2</sub>, and Nb<sub>4</sub>Pt<sub>0.14</sub>SiSb<sub>2</sub>

We have synthesized the three compounds Nb<sub>4</sub>Cu<sub>0.2</sub>SiSb<sub>2</sub>, Nb<sub>4</sub>Pd<sub>0.2</sub>SiSb<sub>2</sub>, and Nb<sub>4</sub>Pt<sub>0.14</sub>SiSb<sub>2</sub>. Here, the void 4b Wyckoff positions in Nb<sub>4</sub>SiSb<sub>2</sub> are partially filled with a transition metal M = Cu, Pd, or Pt, respectively. In Fig. 3, we show a schematic representation of the unit cell along the c-direction and a high symmetry-direction of  $Nb_4M_rSiSb_2$ , where M = Cu, Pt and Pd with x = 0.2, 0.14 and 0.2. The crystal structures of all three compounds were determined using SXRD at 160 K and PXRD diffraction at room temperature.

All samples were found to be single phase by means of PXRD measurements and corresponding Rietveld refinements (ESI†). Atomic compositions were confirmed using EDX analysis (ESI†).

All three structures are in good agreement with the previously reported structure for Nb<sub>4</sub>Pd<sub>0.5</sub>ZSb<sub>2</sub> with Z = Cr, Fe, Co, Ni, Si, where it was thought that a half-occupied Pd 4b site was necessary to stabilize these compounds.17 In contrary to this previous assumption, we found here that the channels were in our case either unoccupied or filled with 0.2 or 0.14 respectively (in case of Pt), independent of the initially used starting stoichiometry. These results indicate that, with improved synthesis methodologies, the continuous solid solution might be accessible in the future. All information regarding the lattice parameters, crystallographic data, and details of the structure refinements are summarized in Table 1.

## 3.4 Electronic properties of Nb<sub>4</sub>Cu<sub>0.2</sub>SiSb<sub>2</sub>, Nb<sub>4</sub>Pd<sub>0.2</sub>SiSb<sub>2</sub> and Nb<sub>4</sub>Pt<sub>0.14</sub>SiSb<sub>2</sub>

In Fig. 4 we present the temperature-dependent resistivity and the normalized low-temperature resistivity  $\rho(T)/\rho(1.6K)$  in a

Table 3 Summary of the physical parameters for Nb<sub>4</sub>SiSb<sub>2</sub>, Nb<sub>4</sub>Cu<sub>0.2</sub>SiSb<sub>2</sub>, Nb<sub>4</sub>Pd<sub>0.2</sub>SiSb<sub>2</sub> and Nb<sub>4</sub>Pt<sub>0.14</sub>SiSb<sub>2</sub>

Parameter	Units	$\mathrm{Nb_4SiSb_2}$	${\rm Nb_4Cu_{0.2}SiSb_2}$	$Nb_4Pd_{0.2}SiSb_2$	$\mathrm{Nb_4Pt_{0.14}SiSb_2}$
$T_{\rm c,resistivity}$	K	1.65	1.16	0.76	0.84
$T_{\rm c,specificheat}$	K	1.59	_	_	_
RRR	_	14.96	4.54	1.56	1.70
$\rho(300)$	mJ Ω cm	2.06	0.70	8.46	2.49
$\rho_0$	mJ Ω cm	0.13	0.15	5.43	1.46
Type of magnetism	<u> </u>	Pauli-paramagnetic	Pauli-paramagnetic	Pauli-paramagnetic	Pauli-paramagnetic
γ	$mJ mol^{-1} K^{-2}$	9.00	7.5	_	
$\Delta C/T_{c}\gamma$	_	1.33	1.2	_	
2⊿(0)	meV	0.47	12	_	
$D(\stackrel{ ightharpoonup}{E_F})$	States eV <sup>-1</sup> per f.u.	3.82	3.18	_	

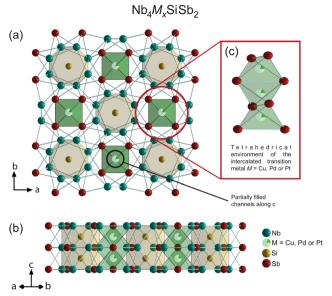


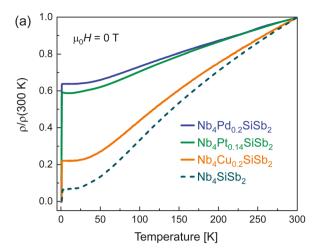
Fig. 3 Schematic representation of the structures of Nb<sub>4</sub>M<sub>x</sub>SiSb<sub>2</sub> from (a) the c-direction and (b) a high symmetry-direction. (c) illustrates the intercalated transition metal M (Cu, Pd, or Pt) in its environment within the <sub>∞</sub>[Sb<sub>4/2</sub>M<sub>x</sub>] channels. The crystal structures were obtained from SXRD refinements

temperature range between T = 400 mK and 1.6 K for Nb<sub>4</sub>Cu<sub>0.2</sub> SiSb<sub>2</sub>, Nb<sub>4</sub>Pd<sub>0.2</sub>SiSb<sub>2</sub> and Nb<sub>4</sub>Pt<sub>0.14</sub>SiSb<sub>2</sub>, measured in zero field  $\mu_0 H = 0 \text{ T.}$ 

We find all three compounds to undergo a transition to a superconducting state at low temperatures. The critical temperature midpoints are determined as  $T_{\rm c,mid} \approx 1.16$  K for Nb<sub>4</sub>Cu<sub>0.2</sub>SiSb<sub>2</sub>,  $T_{\rm c,mid} \approx 0.76$  K for Nb<sub>4</sub>Pd<sub>0.2</sub>SiSb<sub>2</sub> and  $T_{\rm c,mid} \approx$ 0.84 K for Nb<sub>4</sub>Pt<sub>0.14</sub>SiSb<sub>2</sub>. All three compounds with atoms in the void position of Nb<sub>4</sub>SiSb<sub>2</sub> have lower transition temperatures than the parent compound.

For comparison, we have performed specific heat measurements in the normal state of Nb<sub>4</sub>SiSb<sub>2</sub> and Nb<sub>4</sub>Pt<sub>0.14</sub>SiSb<sub>2</sub> (shown in the ESI†). For Nb<sub>4</sub>SiSb<sub>2</sub> we find values for  $\gamma_n$  and  $\beta$ of 8.40 mJ mol<sup>-1</sup> K<sup>-2</sup> and 0.16 mJ mol<sup>-1</sup> K<sup>-4</sup>, respectively. The  $\gamma_n$  value of this fit is in good agreement with the more accurate low-temperature value discussed above. For Nb<sub>4</sub>Pt<sub>0.14</sub>SiSb<sub>2</sub> we find values for  $\gamma_n$  and  $\beta$  of 9.10 mJ mol<sup>-1</sup> K<sup>-2</sup> and 0.31 mJ mol<sup>-1</sup> K<sup>-4</sup>, respectively. We note that the values for  $\gamma_n$  differ only slightly, indicating a small change of the electronic properties upon void position filling. We find, however, that  $\beta$  changes quite strongly. These findings indicate that the decrease of the superconducting transition temperature is likely caused by a change in the phonons, and the vibrations, respectively.

Nb<sub>4</sub>Pd<sub>0.2</sub>SiSb<sub>2</sub> has the lowest critical temperature of the doped compounds, as well as the lowest RRR value of RRR =  $\rho(300 \text{ K})/\rho(1.8 \text{ K}) = 1.56. \text{ Nb}_4\text{Cu}_{0.2}\text{SiSb}_2 \text{ with RRR} = 4.54 \text{ and}$  $Nb_4Pt_{0.14}SiSb_2$  with RRR = 1.70 follow the descending trend observed for the critical temperatures accordingly. These low RRR values correspond to a poor metallic behaviour and are 3 to 24 times smaller than the RRR of the parent compound



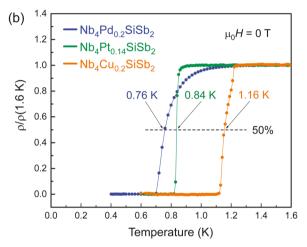


Fig. 4 (a) Temperature-dependent resistivity of Nb<sub>4</sub>Cu<sub>0.2</sub>SiSb<sub>2</sub>,  $\mbox{Nb}_4\mbox{Pd}_{0.2}\mbox{SiSb}_2$  and  $\mbox{Nb}_4\mbox{Pt}_{0.14}\mbox{SiSb}_2$  (a) over the whole temperature range between T = 400 mK and 300 K, and (b) in the vicinity of the superconducting transitions at low temperatures. All measurements were performed in zero field  $\mu_0 H = 0 \text{ T}$ .

Nb<sub>4</sub>SiSb<sub>2</sub>. The pronounced effect on the physical properties on void position doping becomes clearly apparent in the large change of the RRR values. The nature of the change is, however, not only affected by the electronic states, but also by the phonons and by impurity state scattering.

### 4 Conclusion

We have reported on the discovery of the centrosymmetric structure compound Nb<sub>4</sub>SiSb<sub>2</sub>. This phase was found to crystallize in the tetragonal V<sub>4</sub>SiSb<sub>2</sub>-type structure. We found Nb<sub>4</sub>SiSb<sub>2</sub> to undergo a transition to a superconducting state at a critical temperature of  $T_{\rm c} \approx 1.6$  K. The bulk nature of the superconducting transition was evidenced by a clear discontinuity in specific heat, with a normalized specific heat jump of  $\Delta C(T_c)$  $\gamma T_{\rm c}$  = 1.33 mJ mol<sup>-1</sup> K<sup>-2</sup>, close to the weak-coupling BCS value. Furthermore, we have shown that the unoccupied 4b Wyckoff site in Nb<sub>4</sub>SiSb<sub>2</sub> can be partially occupied with the transition metals Cu, Pd, or Pt.

These compounds crystallize in a tetragonal variant of the W<sub>5</sub>Si<sub>3</sub>-type structure with partially occupied channels, extending along the *c*-direction. All three compounds were found to be superconductors with transitions temperatures of  $T_c \approx 1.2 \text{ K}$ for Nb<sub>4</sub>Cu<sub>0.2</sub>SiSb<sub>2</sub>,  $T_{\rm c}\approx 0.8$  K for Nb<sub>4</sub>Pd<sub>0.2</sub>SiSb<sub>2</sub> and  $T_{\rm c}\approx 0.8$  K for Nb<sub>4</sub>Pt<sub>0.14</sub>SiSb<sub>2</sub>. We find that the insertion of a host atom into the void positions strongly affects the electronic and superconducting properties of this material.

Hence, our results indicate that this and related compounds might be promising host structures for the discovery of new superconducting materials, as they allow for a controlled manipulation of the electronic and phononic properties by chemical manipulation.

## Conflicts of interest

There are no conflicts to declare.

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